



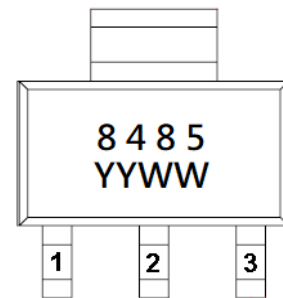
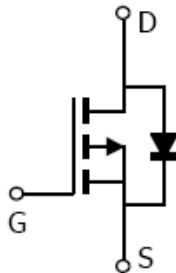
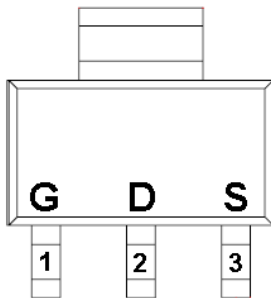
## General Description

AFP8485, P-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge. These devices are particularly suited for low voltage power management, and low in-line power loss are needed in commercial industrial surface mount applications.

## Features

- -100V/-1.5A,  $R_{DS(ON)}=580m\Omega@V_{GS}=-10V$
- -100V/-0.5A,  $R_{DS(ON)}=625m\Omega@V_{GS}=-4.5V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- SOT-223 package design

## Pin Description ( SOT-223 )



## Application

- Motor and Load Control
- LCD TV Inverter & AD/DC Inverter Systems.
- Backlight Inverter for LCD Display
- Load Switch
- CCFL Inverter

## Pin Define

Pin	Symbol	Description
1	G	Gate
2	D	Drain
3	S	Source

## Ordering Information

Part Ordering No.	Part Marking	Package	Unit	Quantity
AFP8485S223RG	8485	SOT-223	Tape & Reel	2500 EA

- ※ YY year code
- ※ WW week code
- ※ AFP8485S223RG : 13" Tape & Reel ; Pb- Free ; Halogen -Free



## Absolute Maximum Ratings

( $T_A=25^\circ\text{C}$  Unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-100	V
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V
Continuous Drain Current( $T_J=150^\circ\text{C}$ )	$I_D$	$T_A=25^\circ\text{C}$	-1.5
		$T_A=70^\circ\text{C}$	-0.5
Pulsed Drain Current	$I_{DM}$	-4.0	A
Continuous Source Current(Diode Conduction)	$I_S$	-1.0	A
Power Dissipation	$P_D$	$T_A=25^\circ\text{C}$	2.8
		$T_A=70^\circ\text{C}$	1.2
Operating Junction Temperature	$T_J$	150	$^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55/150	$^\circ\text{C}$
Thermal Resistance-Junction to Ambient	$R_{\theta JA}$	120	$^\circ\text{C/W}$

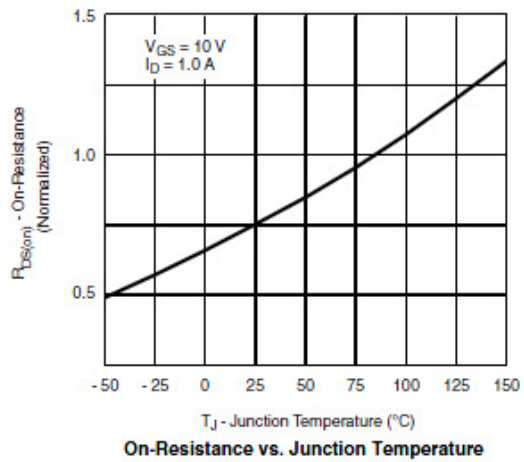
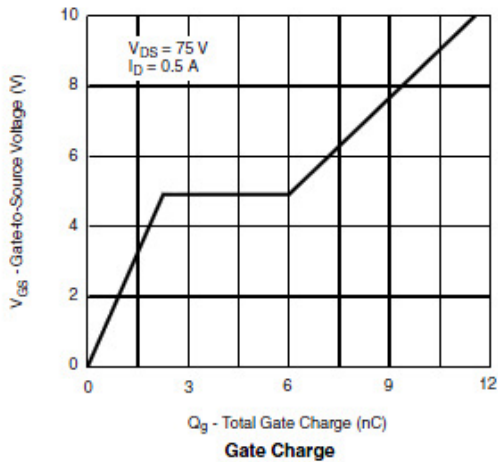
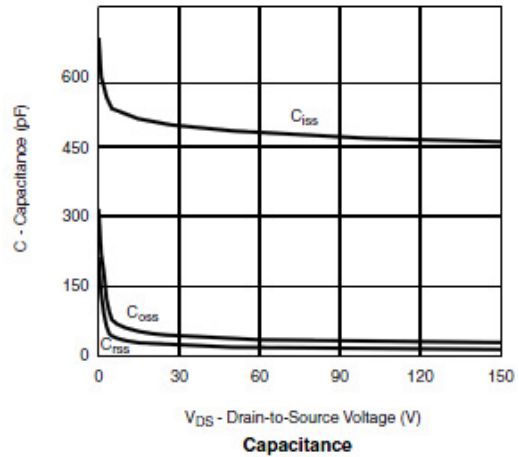
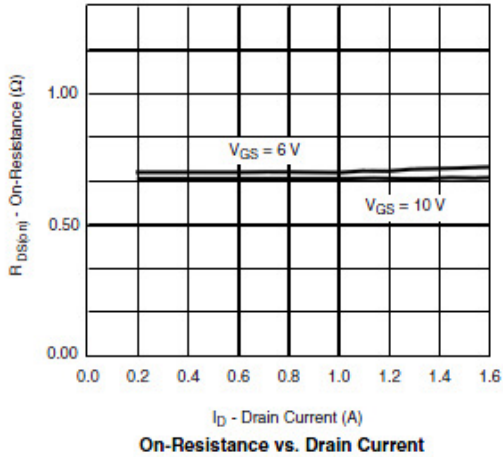
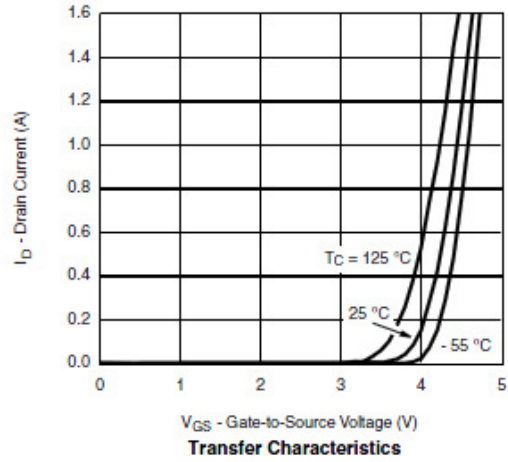
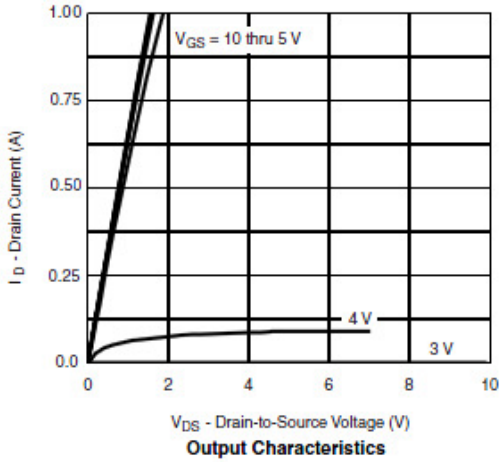
## Electrical Characteristics

( $T_A=25^\circ\text{C}$  Unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Typ	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-250\mu\text{A}$	-100			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1.0		-2.5	
Gate Leakage Current	$I_{GSS}$	$V_{DS}=0V, V_{GS}=\pm 12V$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=-80V, V_{GS}=0V$			-1	uA
		$V_{DS}=-80V, V_{GS}=0V$ $T_J=85^\circ\text{C}$			-30	
On-State Drain Current	$I_{D(on)}$	$V_{DS} \leq -15V, V_{GS}=-10V$	-1.6			A
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-1.5A$		490	580	m $\Omega$
		$V_{GS}=-4.5V, I_D=-0.5A$		525	625	
Forward Transconductance	$g_{FS}$	$V_{DS}=-15V, I_D=-0.5A$		2.8		S
Diode Forward Voltage	$V_{SD}$	$I_S=-0.5A, V_{GS}=0V$		-0.75	-1.3	V
<b>Dynamic</b>						
Total Gate Charge	$Q_g$	$V_{DS}=-75V, V_{GS}=-10V$ $I_D \equiv -0.5A$		9	20	nC
Gate-Source Charge	$Q_{gs}$			2.5		
Gate-Drain Charge	$Q_{gd}$			3.5		
Input Capacitance	$C_{iss}$	$V_{DS}=-25V, V_{GS}=0V$ $f=1\text{MHz}$		450	650	pF
Output Capacitance	$C_{oss}$			50		
Reverse Transfer Capacitance	$C_{rss}$			30		
Turn-On Time	$t_{d(on)}$	$V_{DD}=-75V, R_L=75\Omega$ $I_D \equiv -1.0A, V_{GEN}=-10V$ $R_G=6.0\Omega$		10	20	ns
	$t_r$			15	30	
Turn-Off Time	$t_{d(off)}$			20	40	
	$t_f$			15	30	

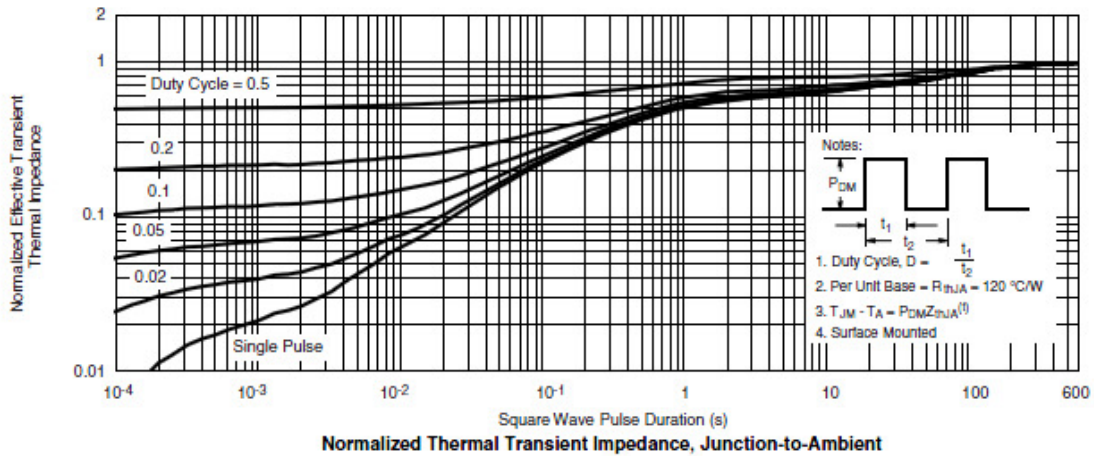
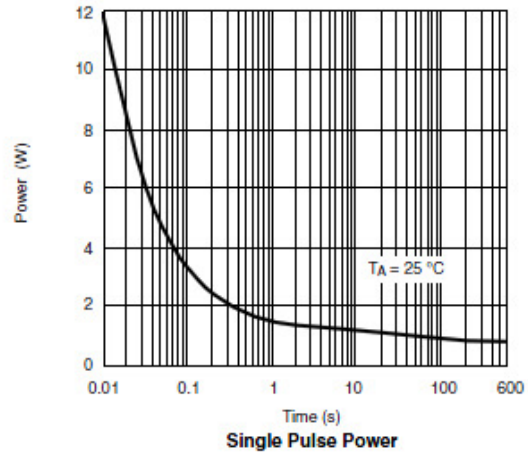
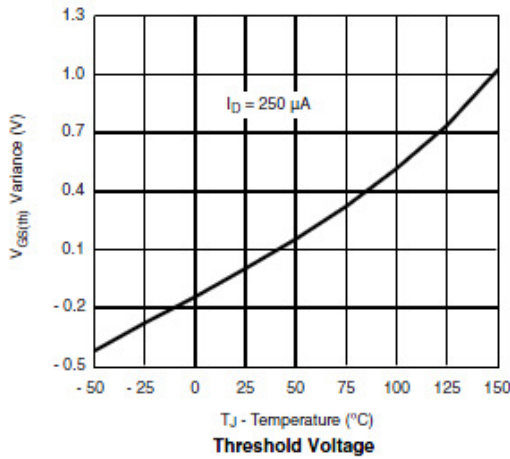
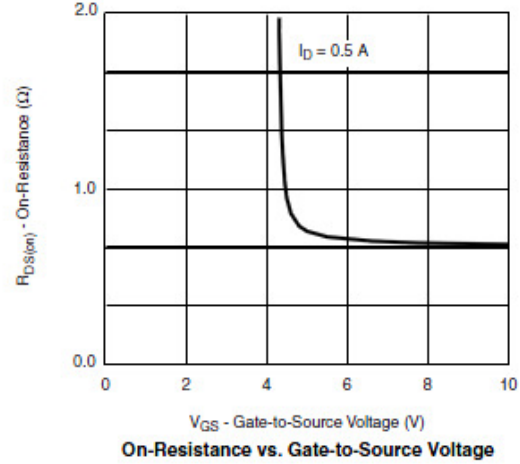
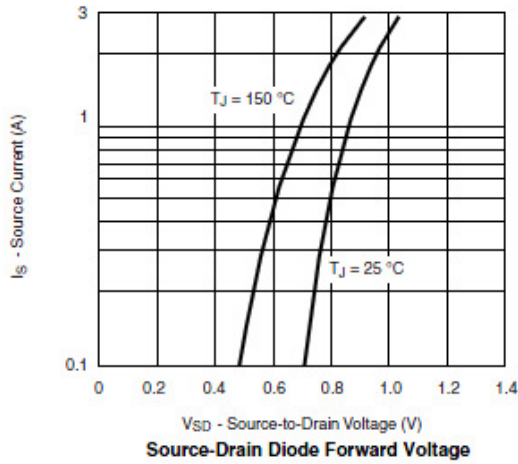


## Typical Characteristics





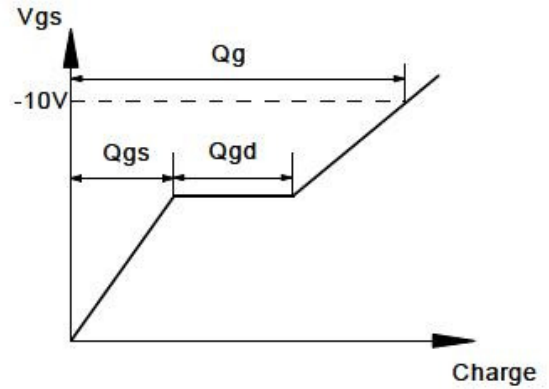
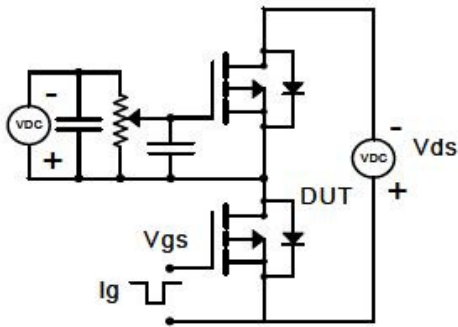
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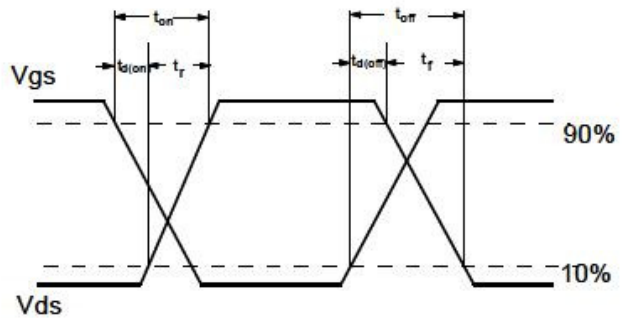
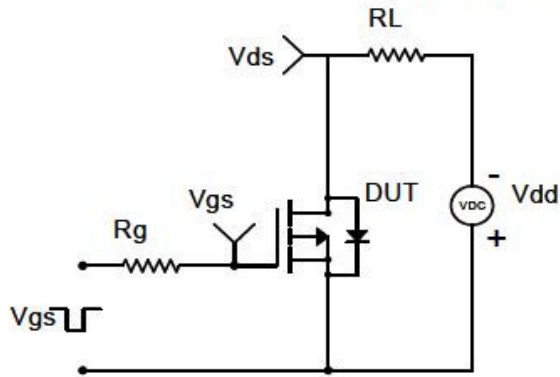


Typical Characteristics

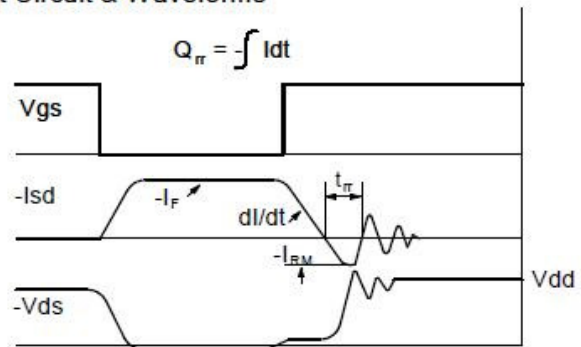
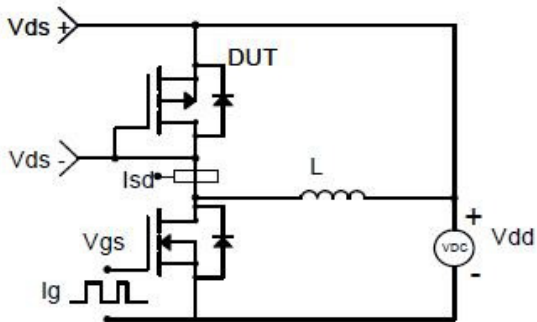
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

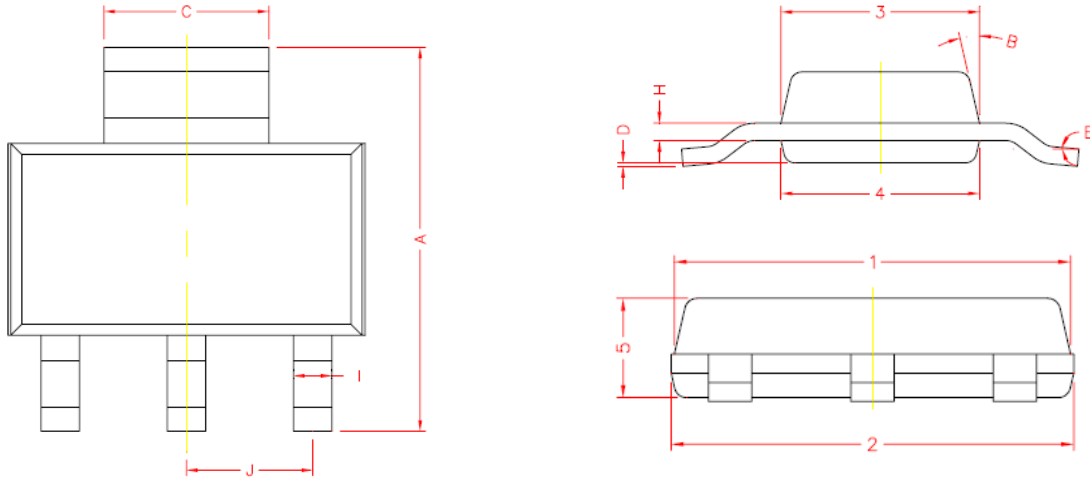


Diode Recovery Test Circuit & Waveforms





**Package Information ( SOT-223 )**



REF.	DIMENSIONS	
	Millimeters	
	Min.	Max.
A	6.70	7.30
C	2.90	3.10
D	0.02	0.10
E	0°	10°
I	0.60	0.80
H	0.25	0.35
B	13° TYP.	
J	2.30 REF.	
1	6.30	6.70
2	6.30	6.70
3	3.30	3.70
4	3.30	3.70
5	1.40	1.80

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